

Notice of References Cited	Application/Control No. 10/538,727		Applicant(s)/Patent Under Reexamination SHITE, HIDEO	
	Examiner YEWEBDAR T. TADESSE		Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,527,860	03-2003	Yoshihara et al.	118/50
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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